

## N-Channel 900V (D-S) Super Junction Power MOSFET

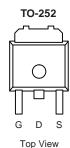
| PRODUCT SUMMARY            |                        |     |  |  |
|----------------------------|------------------------|-----|--|--|
| V <sub>DS</sub> (V)        | 900                    |     |  |  |
| $R_{DS(on)}(\Omega)$       | V <sub>GS</sub> = 10 V | 1.3 |  |  |
| Q <sub>g</sub> (Max.) (nC) | 200                    |     |  |  |
| Q <sub>gs</sub> (nC)       | 24                     |     |  |  |
| Q <sub>gd</sub> (nC)       | 110                    |     |  |  |
| Configuration              | Single                 |     |  |  |

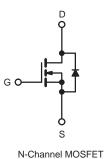
#### **FEATURES**

- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- Isolated Central Mounting Hole
- Fast Switching
- Ease of Paralleling
- Simple Drive Requirements
- Compliant to RoHS Directive 2002/95/EC









| ABSOLUTE MAXIMUM RATINGS (T <sub>C</sub>              | = 25 °C, unl            | ess otherwis            | se noted)                         |                  |          |  |
|---|-------------------------|-------------------------|-----------------------------------|------------------|----------|--|
| PARAMETER   |                         |                         | SYMBOL                            | LIMIT            | UNIT     |  |
| Drain-Source Voltage                                  |                         |                         | $V_{DS}$                          | 900              | V        |  |
| Gate-Source Voltage                                   |                         |                         | $V_{GS}$                          | ± 20             | 1 v      |  |
| Continuous Drain Current                              | V <sub>GS</sub> at 10 V | T <sub>C</sub> = 25 °C  | I_                                | 5                |          |  |
| Continuous Drain Current                              |                         | T <sub>C</sub> = 100 °C | I <sub>D</sub>                    | 3.9              | Α        |  |
| Pulsed Drain Current <sup>a</sup>                     |                         |                         | I <sub>DM</sub>                   | 21               |          |  |
| Linear Derating Factor                                |                         |                         |                                   | 1.5              | W/°C     |  |
| Single Pulse Avalanche Energy <sup>b</sup>            |                         |                         | E <sub>AS</sub>                   | 770              | mJ       |  |
| Repetitive Avalanche Current <sup>a</sup>             |                         |                         | I <sub>AR</sub>                   | 7.8              | Α        |  |
| Repetitive Avalanche Energy <sup>a</sup>              |                         |                         | E <sub>AR</sub>                   | 19               | mJ       |  |
| Maximum Power Dissipation $T_C = 25  ^{\circ}C$       |                         |                         | P <sub>D</sub>                    | 190              | W        |  |
| Peak Diode Recovery dV/dt <sup>c</sup>                |                         |                         | dV/dt                             | 2.0              | V/ns     |  |
| Operating Junction and Storage Temperature Range      |                         |                         | T <sub>J</sub> , T <sub>stg</sub> | - 55 to + 150    | °C       |  |
| Soldering Recommendations (Peak Temperature) for 10 s |                         |                         | -                                 | 300 <sup>d</sup> |          |  |
| Mounting Torque                                       | 6-32 or M3 screw        |                         |                                   | 10               | lbf ⋅ in |  |
| Mounting Torque                                       |                         |                         |                                   | 1.1              | N · m    |  |

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b.  $V_{DD} = 50$  V, starting  $T_J = 25$  °C, L = 23 mH,  $R_g = 25$   $\Omega$ ,  $I_{AS} = 7.8$  A (see fig. 12). c.  $I_{SD} \le 7.8$  A, dl/dt  $\le 140$  A/ $\mu$ s,  $V_{DD} \le 600$  V,  $T_J \le 150$  °C. d. 1.6 mm from case.

<sup>\*</sup> Pb containing terminations are not RoHS compliant, exemptions may apply



| THERMAL RESISTANCE RATINGS          |                   |      |      |      |  |  |
|-------------------------------------|-------------------|------|------|------|--|--|
| PARAMETER                           | SYMBOL            | TYP. | MAX. | UNIT |  |  |
| Maximum Junction-to-Ambient         | R <sub>thJA</sub> | -    | 40   |      |  |  |
| Case-to-Sink, Flat, Greased Surface | R <sub>thCS</sub> | 0.24 | -    | °C/W |  |  |
| Maximum Junction-to-Case (Drain)    | R <sub>thJC</sub> | -    | 0.65 |      |  |  |

| PARAMETER                                 | SYMBOL                | TEST CONDITIONS   |   | MIN. | TYP.             | MAX.       | UNIT |
|---|-----------------------|---|---|------|------------------|------------|------|
| Static                                    |                       |   |   |      |                  | ,          |      |
| Drain-Source Breakdown Voltage            | V <sub>DS</sub>       | $V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$   |   | 900  | -                | -          | V    |
| V <sub>DS</sub> Temperature Coefficient   | $\Delta V_{DS}/T_{J}$ | Reference   | e to 25 °C, I <sub>D</sub> = 1 mA   | -    | 0.98             | -          | V/°C |
| Gate-Source Threshold Voltage             | V <sub>GS(th)</sub>   | V <sub>DS</sub> :   | $V_{DS} = V_{GS}, I_{D} = 250 \mu\text{A}$  |      | -                | 4.0        | V    |
| Gate-Source Leakage                       | I <sub>GSS</sub>      |   | V <sub>GS</sub> = ± 20 V  |      | -                | ± 100      | nA   |
| Zero Gate Voltage Drain Current           | I <sub>DSS</sub>      |   | $V_{DS} = 900 \text{ V}, V_{GS} = 0 \text{ V}$ $V_{DS} = 720 \text{ V}, V_{GS} = 0 \text{ V}, T_J = 125 ^{\circ}\text{C}$ |      | -                | 100<br>500 | μΑ   |
| Drain-Source On-State Resistance          | R <sub>DS(on)</sub>   |   | $I_D = 3.7 \text{ A}^b$   | _    | 1.3              | -          | Ω    |
| Forward Transconductance                  | 9fs                   |   | = 100 V, I <sub>D</sub> = 3.7 A <sup>b</sup>  | 5.6  | _                | -          | S    |
| Dynamic                                   | <u> </u>              |   | _   | L    |                  |            |      |
| Input Capacitance                         | C <sub>iss</sub>      | V 0V  |   | -    | 3100             | -          |      |
| Output Capacitance                        | C <sub>oss</sub>      | 1   | $V_{GS} = 0 V$ ,<br>$V_{DS} = 25 V$ ,   | -    | 800              | -          | pF   |
| Reverse Transfer Capacitance              | C <sub>rss</sub>      | f = 1   | .0 MHz, see fig. 5  | -    | 490              | -          |      |
| Total Gate Charge                         | Qg                    |   | $V_{GS} = 10 \text{ V}$ $I_D = 3.8 \text{ A}, V_{DS} = 400 \text{ V},$ see fig. 6 and 13 <sup>b</sup>                     |      | -                | 200        | nC   |
| Gate-Source Charge                        | Q <sub>gs</sub>       | V <sub>GS</sub> = 10 V  |   |      | -                | 24         |      |
| Gate-Drain Charge                         | $Q_{gd}$              |   |   |      | -                | 110        |      |
| Turn-On Delay Time                        | $t_{d(on)}$           |   |   |      | 19               | -          | - ns |
| Rise Time                                 | t <sub>r</sub>        | $V_{DD} = 400 \text{ V, } I_{D} = 3.8 \text{ A,}$ $R_{g} = 6.2 \Omega, R_{D} = 52 \Omega$ see fig. $10^{b}$ |   | -    | 38               | -          |      |
| Turn-Off Delay Time                       | $t_{d(off)}$          |   |   | -    | 120              | -          |      |
| Fall Time                                 | t <sub>f</sub>        |   |   | -    | 39               | -          |      |
| Internal Drain Inductance                 | $L_D$                 | Between lead,<br>6 mm (0.25") from<br>package and center of<br>die contact                                  |   | -    | 5.0              | -          | mll  |
| Internal Source Inductance                | L <sub>S</sub>        |   |   | -    | 13               | -          | - nH |
| Drain-Source Body Diode Characteristic    | s                     |   |   |      |                  | •          |      |
| Continuous Source-Drain Diode Current     | I <sub>S</sub>        | MOSFET symbol showing the integral reverse p - n junction diode   |   | -    | -                | 5.0        |      |
| Pulsed Diode Forward Current <sup>a</sup> | I <sub>SM</sub>       |   |   | -    | -                | 21         | A    |
| Body Diode Voltage                        | V <sub>SD</sub>       | T <sub>J</sub> = 25 °C, I <sub>S</sub> = 3.8 A, V <sub>GS</sub> = 0 V <sup>b</sup>                          |   | -    | -                | 1.8        | V    |
| Body Diode Reverse Recovery Time          | t <sub>rr</sub>       | T <sub>J</sub> = 25 °C, I <sub>F</sub> = 3.8 A,<br>dl/dt = 100 A/μs <sup>b</sup>                            |   | -    | 650              | 980        | ns   |
| Body Diode Reverse Recovery Charge        | Q <sub>rr</sub>       |   |   | -    | 3.8              | 5.7        | μC   |
| Forward Turn-On Time                      | t <sub>on</sub>       | Intrinsic turn-on time is negligible (turn-on is dominated by $L_S$ and $L_\Gamma$                          |   |      | L <sub>D</sub> ) |            |      |

### Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Pulse width  $\leq$  300 µs; duty cycle  $\leq$  2 %.



### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

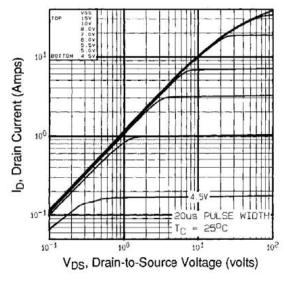


Fig. 1 - Typical Output Characteristics,  $T_C$  = 25 °C

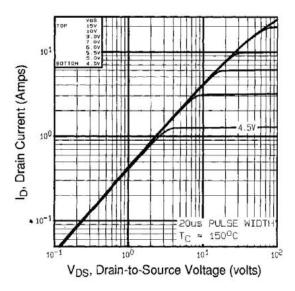


Fig. 2 - Typical Output Characteristics,  $T_C = 150$  °C

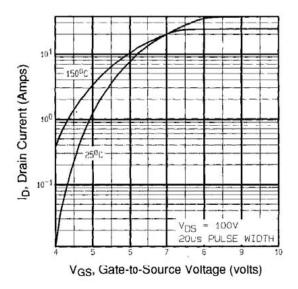


Fig. 3 - Typical Transfer Characteristics

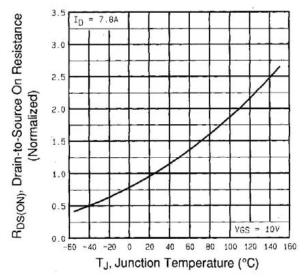


Fig. 4 - Normalized On-Resistance vs. Temperature



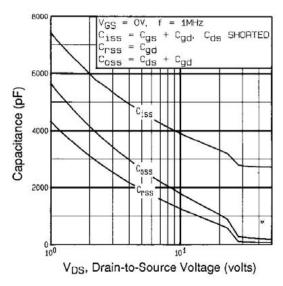


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

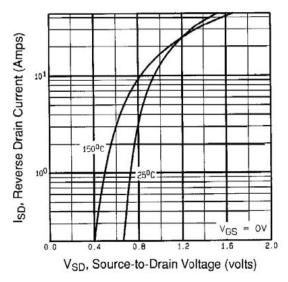


Fig. 7 - Typical Source-Drain Diode Forward Voltage

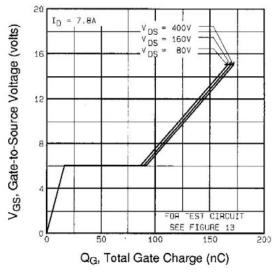


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

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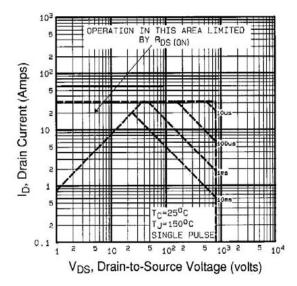


Fig. 8 - Maximum Safe Operating Area



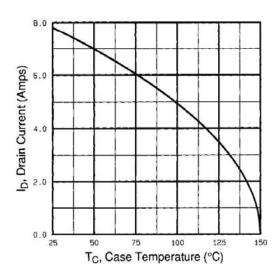


Fig. 9 - Maximum Drain Current vs. Case Temperature

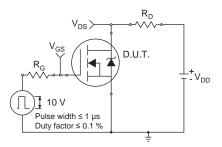


Fig. 10a - Switching Time Test Circuit

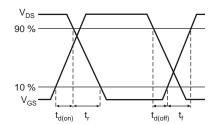


Fig. 10b - Switching Time Waveforms

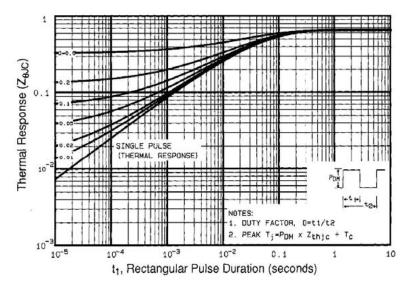


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



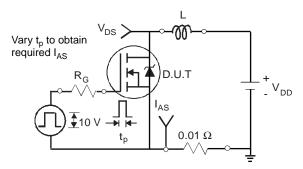


Fig. 12a - Unclamped Inductive Test Circuit

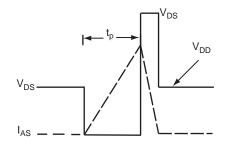


Fig. 12b - Unclamped Inductive Waveforms

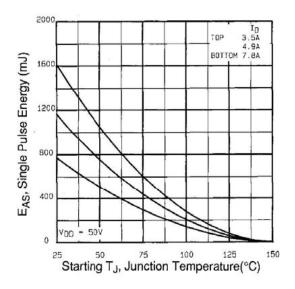


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

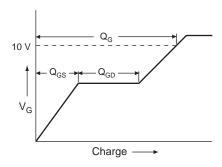


Fig. 13a - Basic Gate Charge Waveform

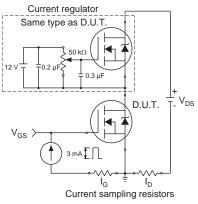
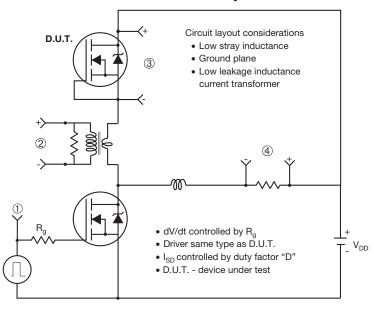


Fig. 13b - Gate Charge Test Circuit



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#### Peak Diode Recovery dV/dt Test Circuit



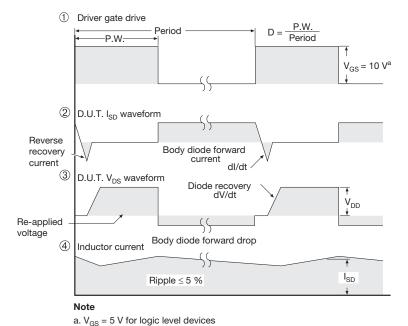
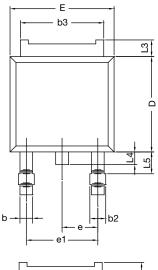
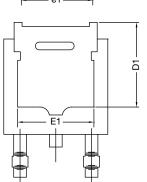


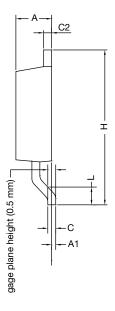
Fig. 14 - For N-Channel



# **TO-252AA CASE OUTLINE**







|                                 | MILLIN   | METERS | INC       | HES   |  |
|---------------------------------|----------|--------|-----------|-------|--|
| DIM.                            | MIN.     | MAX.   | MIN.      | MAX.  |  |
| Α                               | 2.18     | 2.38   | 0.086     | 0.094 |  |
| A1                              | =        | 0.127  | =         | 0.005 |  |
| b                               | 0.64     | 0.88   | 0.025     | 0.035 |  |
| b2                              | 0.76     | 1.14   | 0.030     | 0.045 |  |
| b3                              | 4.95     | 5.46   | 0.195     | 0.215 |  |
| С                               | 0.46     | 0.61   | 0.018     | 0.024 |  |
| C2                              | 0.46     | 0.89   | 0.018     | 0.035 |  |
| D                               | 5.97     | 6.22   | 0.235     | 0.245 |  |
| D1                              | 5.21     | -      | 0.205     | =     |  |
| E                               | 6.35     | 6.73   | 0.250     | 0.265 |  |
| E1                              | 4.32     | -      | 0.170     | -     |  |
| Н                               | 9.40     | 10.41  | 0.370     | 0.410 |  |
| е                               | 2.28     | BSC    | 0.090 BSC |       |  |
| e1                              | 4.56 BSC |        | 0.180 BSC |       |  |
| L                               | 1.40     | 1.78   | 0.055     | 0.070 |  |
| L3                              | 0.89     | 1.27   | 0.035     | 0.050 |  |
| L4                              | -        | 1.02   | -         | 0.040 |  |
| L5                              | 1.14     | 1.52   | 0.045     | 0.060 |  |
| ECN: X12-0247-Rev. M, 24-Dec-12 |          |        |           |       |  |

#### Note

• Dimension L3 is for reference only.



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